


<b>Search Notes</b>  	<b>Application/Control No.</b>  10753491	<b>Applicant(s)/Patent Under Reexamination</b>  HALNA DU FRETAY ET AL.
	<b>Examiner</b>  MICHAEL C LAI	<b>Art Unit</b>  2457

### SEARCHED

Class	Subclass	Date	Examiner
709	236	2/7/08	Lai
Inventor search		5/27/08	Lai
709	248	12/16/09	Lai
370	473	12/16/09	Lai

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (text search)	5/29/08	Lai
EAST (text search)	5/13/09	Lai
EIC search (fast and focus)	5/15/09	Lai
Consulted Moustafa Meky for allowable subject matters	12/8/09	Lai
Consulted Kim Huynh (WQAS) for 112 6th paragraph issues	12/9/09	Lai
EIC fast and focus search (NPL and patent)	12/9/09	Lai
Consulted Yves Dalencourt for allowable subject matters and examiner's amendment	12/15/09	Lai
EAST (updated search)	6/10/10	Lai
NPL Multi-search	6/10/10	Lai
Consulted Lashonda Jacobs for proposed amendment claims 29 and 58X	6/8/10	Lai

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	236	6/10/10	Lai
Double patenting		6/10/10	Lai

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